

## MM74HCT00 Quad 2 Input NAND Gate

### General Description

The MM74HCT00 is a NAND gates fabricated using advanced silicon-gate CMOS technology which provides the inherent benefits of CMOS—low quiescent power and wide power supply range. This device is input and output characteristic and pin-out compatible with standard 74LS logic families. All inputs are protected from static discharge damage by internal diodes to  $V_{CC}$  and ground.

MM74HCT devices are intended to interface between TTL and NMOS components and standard CMOS devices.

These parts are also plug-in replacements for LS-TTL devices and can be used to reduce power consumption in existing designs.

### Features

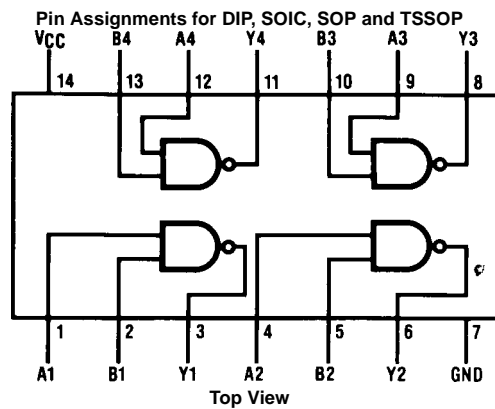
- TTL, LS pin-out and threshold compatible
- Fast switching:  $t_{PLH}$ ,  $t_{PHL}$ =14 ns (typ)
- Low power: 10  $\mu$ W at DC
- High fan out, 10 LS-TTL loads

### Ordering Code:

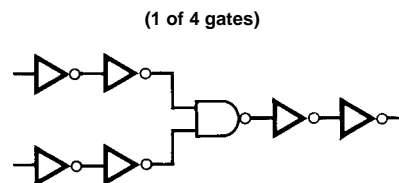
Order Number	Package Number	Package Description
MM74HCT00M	M14A	14-Lead Small Outline Integrate Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
MM74HCT00SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
MM74HCT00MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
MM74HCT00N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### Connection Diagram



### Logic Diagram



**Absolute Maximum Ratings** (Note 1)

(Note 2)

Supply Voltage ( $V_{CC}$ )	-0.5 to +7.0V
DC Input Voltage ( $V_{IN}$ )	-1.5 to $V_{CC}+1.5V$
DC Output Voltage ( $V_{OUT}$ )	-0.5 to $V_{CC}+0.5V$
Clamp Diode Current ( $I_{IK}, I_{OK}$ )	$\pm 20$ mA
DC Output Current, per pin ( $I_{OUT}$ )	$\pm 25$ mA
DC $V_{CC}$ or GND Current, per pin ( $I_{CC}$ )	$\pm 50$ mA
Storage Temperature Range ( $T_{STG}$ )	-65°C to +150°C
Power Dissipation ( $P_D$ )	
(Note 3)	600 mW
S.O. Package only	500 mW
Lead Temperature ( $T_L$ )	
(Soldering 10 seconds)	260°C

**Recommended Operating Conditions**

	Min	Max	Units
Supply Voltage ( $V_{CC}$ )	4.5	5.5	V
DC Input or Output Voltage ( $V_{IN}, V_{OUT}$ )	0	$V_{CC}$	V
Operating Temperature Range ( $T_A$ )	-40	+85	°C
Input Rise or Fall Times ( $t_r, t_f$ )		500	ns

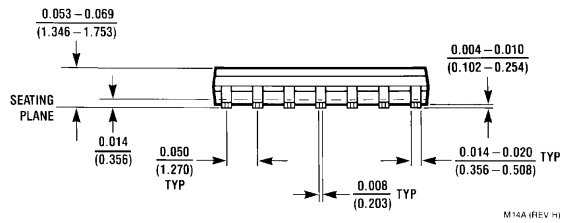
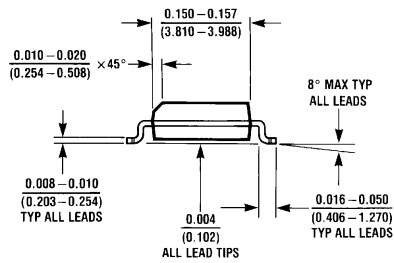
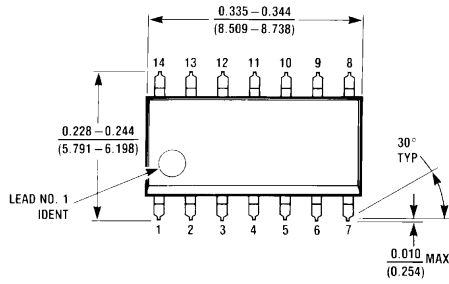
**Note 1:** Absolute Maximum Ratings are those values beyond which damage to the device may occur.**Note 2:** Unless otherwise specified all voltages are referenced to ground.**Note 3:** Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C.**DC Electrical Characteristics** $V_{CC} = 5V \pm 10\%$  (unless otherwise specified)

Symbol	Parameter	Conditions	$T_A = 25^\circ\text{C}$		$T_A = -40$ to $85^\circ\text{C}$	$T_A = -55$ to $125^\circ\text{C}$	Units	
			Typ	Guaranteed Limits				
$V_{IH}$	Minimum HIGH Level Input Voltage			2.0	2.0	2.0	V	
$V_{IL}$	Maximum LOW Level Input Voltage			0.8	0.8	0.8	V	
$V_{OH}$	Minimum HIGH Level Output Voltage	$V_{IN} = V_{IH}$ or $V_{IL}$		$V_{CC}$	$V_{CC}-0.1$	$V_{CC}-0.1$	$V_{CC}-0.1$	V
		$ I_{OUT}  = 20 \mu\text{A}$		4.2	3.98	3.84	3.7	V
		$ I_{OUT}  = 4.0 \text{ mA}, V_{CC} = 4.5V$ $ I_{OUT}  = 4.8 \text{ mA}, V_{CC} = 5.5V$		5.2	4.98	4.84	4.7	V
$V_{OL}$	Maximum LOW Level Voltage	$V_{IN} = V_{IH}$		0	0.1	0.1	0.1	V
		$ I_{OUT}  = 20 \mu\text{A}$		0.2	0.26	0.33	0.4	V
		$ I_{OUT}  = 4.0 \text{ mA}, V_{CC} = 4.5V$ $ I_{OUT}  = 4.8 \text{ mA}, V_{CC} = 5.5V$		0.2	0.26	0.33	0.4	V
$I_{IN}$	Maximum Input Current	$V_{IN} = V_{CC}$ or GND, $V_{IH}$ or $V_{IL}$		$\pm 0.05$	$\pm 0.5$	$\pm 1.0$	$\mu\text{A}$	
$I_{CC}$	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0 \mu\text{A}$		1.0	10	40	$\mu\text{A}$	
		$V_{IN} = 2.4V$ or $0.5V$ (Note 4)	0.18	0.3	0.4	0.5	mA	

**Note 4:** This is measured per input with all other inputs held at  $V_{CC}$  or ground.

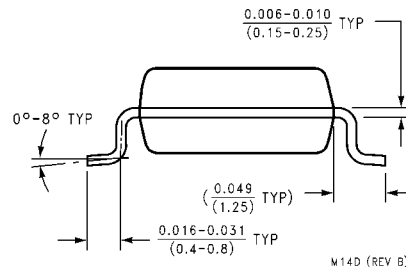
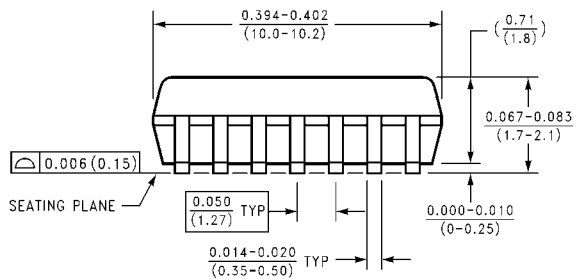
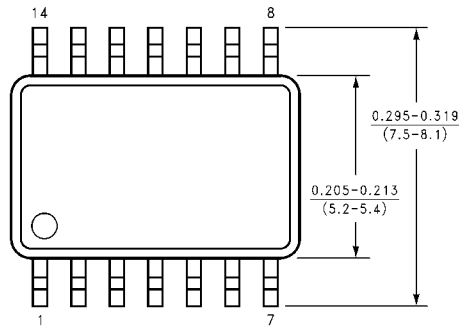
AC Electrical Characteristics							
$V_{CC} = 5.0V$ , $t_r = t_f = 6 \text{ ns}$ , $C_L = 15 \text{ pF}$ , $T_A = 25^\circ\text{C}$ (unless otherwise noted)							
Symbol	Parameter	Conditions	Typ	Guaranteed Limit	Units		
$t_{PLH}$ , $t_{PHL}$	Maximum Propagation Delay		14	18	ns		
AC Electrical Characteristics							
$V_{CC} = 5.0V \pm 10\%$ , $t_r = t_f = 6 \text{ ns}$ , $C_L = 50 \text{ pF}$ (unless otherwise noted)							
Symbol	Parameter	Conditions	$T_A = 25^\circ\text{C}$		$T_A = -40 \text{ to } 85^\circ\text{C}$	$T_A = -55 \text{ to } 125^\circ\text{C}$	Units
			Typ	Guaranteed Limits			
$t_{PLH}$ , $t_{PHL}$	Maximum Propagation Delay		18	23	29	35	ns
$t_{THL}$ , $t_{TLH}$	Maximum Output Rise & Fall Time		8	15	19	22	ns
$C_{PD}$	Power Dissipation Capacitance	(Note 5)	30				pF
$C_{IN}$	Input Capacitance		5	10	10	10	pF
<p><b>Note 5:</b> <math>C_{PD}</math> determines the no load dynamic power consumption, <math>P_D = C_{PD} V_{CC}^2 f + I_{CC} V_{CC}</math>, and the no load dynamic current consumption, <math>I_S = C_{PD} V_{CC} f + I_{CC}</math>.</p>							

**Physical Dimensions** inches (millimeters) unless otherwise noted



M14A (REV H)

**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow  
Package Number M14A**

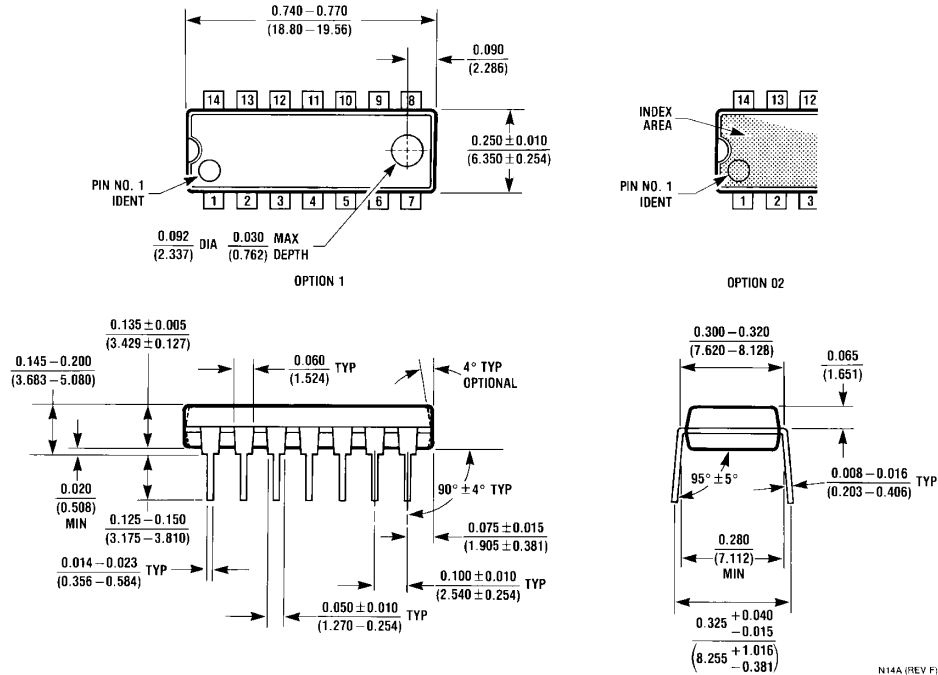


M14D (REV B)

**14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide  
Package Number M14D**



**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



14-Line Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

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